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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10580352 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>TAKASHI ET AL. |
|  | <b>Examiner</b><br><br>Stefan Krueer           | <b>Art Unit</b><br><br>3654  |

| SEARCHED |                                    |            |          |
|----------|------------------------------------|------------|----------|
| Class    | Subclass                           | Date       | Examiner |
| 187      | 351,356,367,378,379, 371, 372, 374 | 03/30/2008 | SHK      |
| 104      | 252, 257                           |            |          |
| 187      | 414                                | 06/19/2008 | SHK      |
| B66B     | 5/00, 5/04, 7/00, 7/02             |            |          |
| 104      | 127 - 128                          |            |          |

| SEARCH NOTES |            |          |
|--------------|------------|----------|
| Search Notes | Date       | Examiner |
| PLUS         | 03/30/2008 | SHK      |
| 248 + word   |            |          |

| INTERFERENCE SEARCH |          |            |          |
|---------------------|----------|------------|----------|
| Class               | Subclass | Date       | Examiner |
| US PGPUBS           |          | 06/19/2008 | SHK      |